



SPS proton Irradiation Tests at JSI

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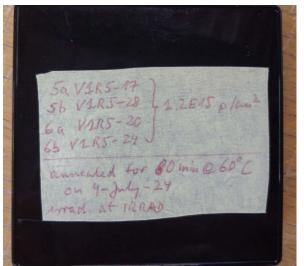
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HGTD Sensor Meeting 16 June 2025

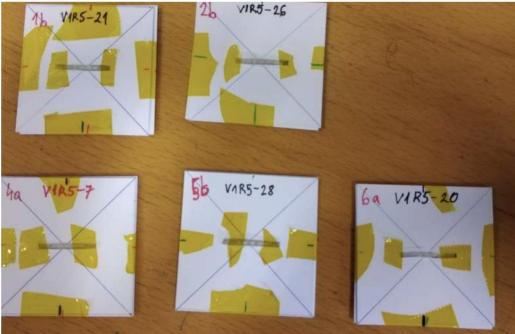


CERN SPS 24 GeV proton irradiation testing at JSI





- Proton Gaussian beam narrow (FWHMx = 7.8 mm, FWHMy = 9.7 mm)
- Wafer V1R5 irradiated Samples irradiated to fluences up to: 4e14 p/cm², 8e14 p/cm² and 1.2e15 p/cm²
- IV-CV, TCT and Sr90 measurements were carried out at JSI
- Samples annealed for 80 min
 @ 60 °C
- V_{gl} before irradiation is estimated ~25 V at room temp (@CERN ~27 V) for this wafer

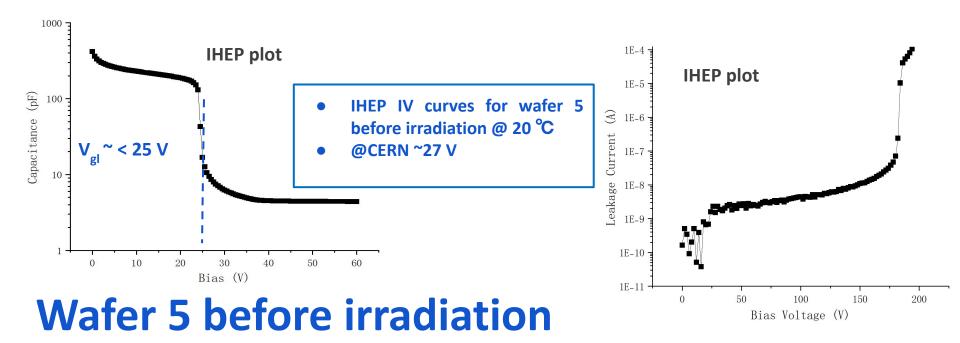


Wafer V1R5				
Board	Sample	Complementary card	Complementary sample	
1a	V1R5-19	1b	V1R5-21	
2a	V1R5-16	2b	V1R5-26	
3a	V1R5-52	4a	V1R5-7	
4b	V1R5-25	4a	V1R5-7	
5a	V1R5-17	5b	V1R5-28	
6a	V1R5-20	6b	V1R5-24	

- 1×1 LGAD and PIN structures are overlapped to ensure identical irradiation conditions for accurate comparison.
- Front (LGAD) and back (PIN) cards enable simultaneous measurements, improving dosimetry precision.

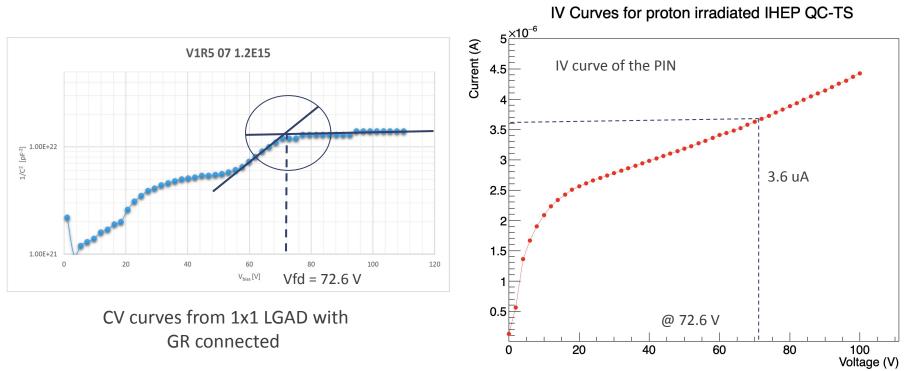
	Fluence (1e14 neq/cm2)	·IV LGAD2 (next to 1x1)				2.94E+14	тст	
		Vgl	Vfd	Vbd (500 nA)	I(PIN) at 20C, Vfd	fluence	Vgl1	Vgl2
Jan 2024								
V1R5	20WS11010005XY							
V1R5-18	0	24.7	57	180	5	1.47E+15	24.7	24.1
V1R5-22	0	24.3	37	175			24.0	24.0
V1R5-42	0	24.6	37	197			24.3	24.1
V1R6 50	\$	21.1		197			23.8	24.0
V1R5-52	0	24.5	40	200			24.4	24.3
V 113-49	U	24.0	30	207			20.9	23.9

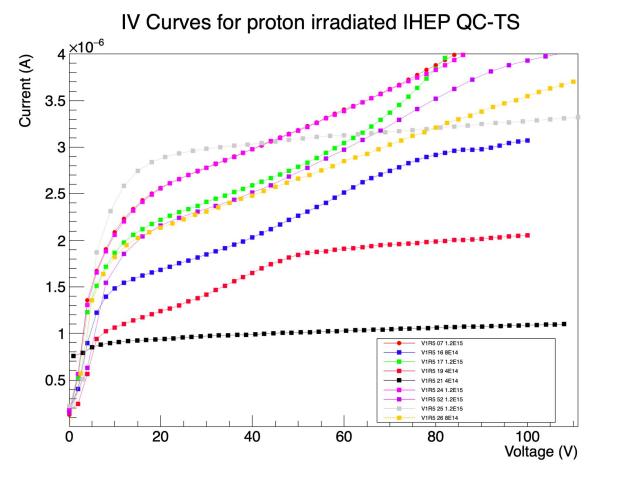
JSI results before irradiations @ 20 °C



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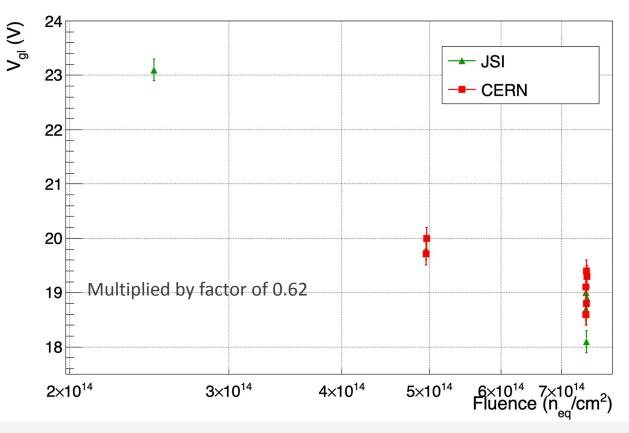
Dosimetry evaluation





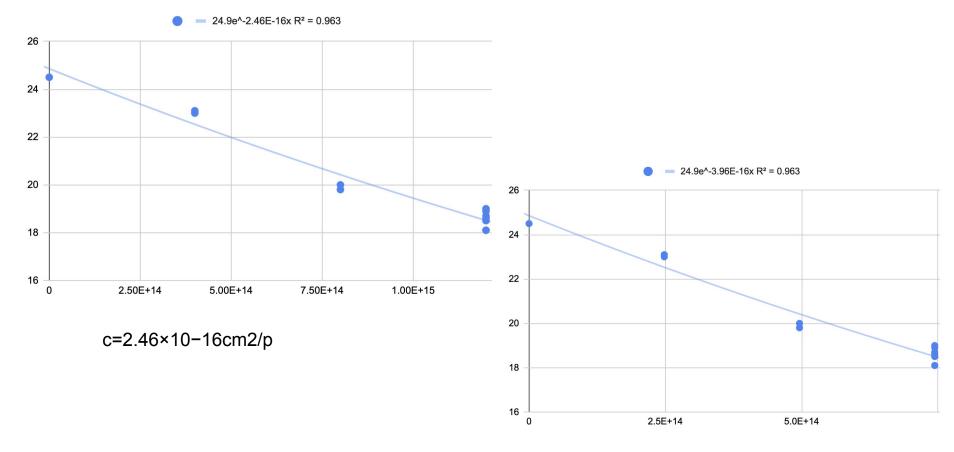
Proton irradiations data

JSI vs CERN CV-IV measurements



- Values are generally in good agreement across the fluence range
 - Absolute percent differences range from 0.00% to 4.21%, with an average deviation of approximately 1.72%

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c=3.96×10-16cm2/neq